


<p align="center"><b>Search Notes</b></p> 	<p><b>Application/Control No.</b></p> <p>09868221</p>	<p><b>Applicant(s)/Patent Under Reexamination</b></p> <p>TITMUSS ET AL.</p>
	<p><b>Examiner</b></p> <p>DJENANE M BAYARD</p>	<p><b>Art Unit</b></p> <p>2444</p>

SEARCHED			
Class	Subclass	Date	Examiner
709	227, 231, 246	3/29/10	db
709	217, 218, 219, 223, 227, 231, 246	9/10/10	db

SEARCH NOTES			
Search Notes		Date	Examiner
East		3/28/10	db
NPL (google Scholar)		3/28/10	db
East		9/10/10	db
Double Patenting search		9/10/10	db
NPL Googl scholar		9/10/10	db

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
709	217, 218, 219, 223, 227, 231, 246	9/10/10	db

/D. M. B./  
Examiner, Art Unit 2444